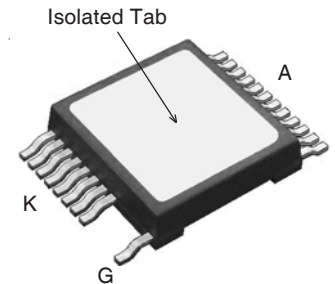
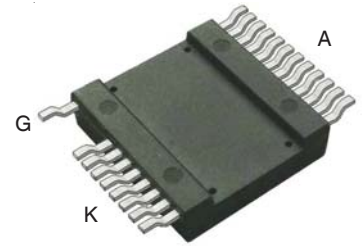
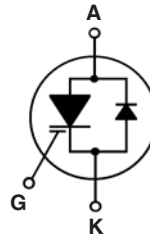


# 1500V MOS Gated Thyristor w/ Anti-Parallel Diode

## MMIX1H60N150V1

### $V_{DM} = 1500V$

(Electrically Isolated Tab)



G = Gate                      K = Cathode  
A = Anode

Symbol	Test Conditions	Maximum Ratings	
$V_{DM}$	$T_J = 25^\circ\text{C to } 150^\circ\text{C}$	1500	V
$V_{GK}$	Continuous	$\pm 30$	V
$V_{GK}$	Transient	$\pm 40$	V
$I_{TSM}$	$T_C = 25^\circ\text{C}, 1\mu\text{s}$	32.0	kA
	$T_C = 25^\circ\text{C}, 10\mu\text{s}$	11.8	kA
$P_D$	$T_C = 25^\circ\text{C}$	446	W
$T_J$		-55 ... +150	$^\circ\text{C}$
$T_{JM}$		150	$^\circ\text{C}$
$T_{stg}$		-55 ... +150	$^\circ\text{C}$
$T_L$	Maximum Lead Temperature for Soldering	300	$^\circ\text{C}$
$T_{SOLD}$	1.6 mm (0.062 in.) from Case for 10s	260	$^\circ\text{C}$
$V_{ISOL}$	50/60Hz, 1 minute	2500	V~
$F_C$	Mounting Force	50..200/11..45	N/lb
<b>Weight</b>		8	g

Symbol	Test Conditions ( $T_J = 25^\circ\text{C}$ , Unless Otherwise Specified)	Characteristic Values		
		Min.	Typ.	Max.
$V_{BR}$	$I_A = 250\mu\text{A}, V_{GK} = 0V$	1500		V
$V_{GK(th)}$	$I_A = 250\mu\text{A}, V_{AK} = V_{GK}$	2.5		5.0 V
$V_T$	$I_T = 1000A, V_{GK} = 15V$		4.6	6.0 V
$r_T$	$I_T > I_L, V_{GK} = 15V$		1.2	m $\Omega$
$V_{BO}$	$V_{GK} = 15V$		4.8	V
$I_D$	$V_{AK} = 1500V, V_{GK} = 0V$ $T_J = 125^\circ\text{C}$			15 $\mu\text{A}$
				1.5 mA
$I_L$			400	A
$I_H$			350	A
$I_{GKS}$	$V_{AK} = 0V, V_{GK} = \pm 30V$			$\pm 200$ nA

### Features

- Silicon Chip on Direct-Copper Bond (DCB) Substrate
- Isolated Mounting Surface
- Anti-Parallel Diode
- 2500V~ Electrical Isolation
- Very High Current Capability

### Advantages

- High Power Density
- Low Gate Drive Requirement

### Applications

- Capacitive Discharge Circuits
- Ignition Circuits
- Solid State Surge Protection

Symbol Test Conditions ( $T_J = 25^\circ\text{C}$ Unless Otherwise Specified)		Characteristic Values		
		Min.	Typ.	Max.
$C_{iks}$ $C_{oks}$ $C_{rks}$	$V_{AK} = 25\text{V}, V_{GK} = 0\text{V}, f = 1\text{MHz}$		5120	pF
			340	pF
			84	pF
$Q_{g(on)}$ $Q_{gk}$ $Q_{ga}$	$I_C = 60\text{A}, V_{GK} = 15\text{V}, V_{AK} = 600\text{V}$		180	nC
			33	nC
			62	nC
$t_{ri}$ $t_d$	<b>Capacitive Discharge, <math>T_J = 25^\circ\text{C}</math></b> $I_A = 2000\text{A}, V_{GK} = 15\text{V}, R_G = 1\Omega$ $V_{AK} = 1000\text{V}, L < 20\text{nH}, \text{Notes 2 \& 3}$		100	ns
			50	ns
$t_{ri}$ $t_d$	<b>Capacitive Discharge, <math>T_J = 125^\circ\text{C}</math></b> $I_A = 2000\text{A}, V_{GK} = 15\text{V}, R_G = 1\Omega$ $V_{AK} = 1000\text{V}, L < 20\text{nH}, \text{Notes 2 \& 3}$		100	ns
			50	ns
$R_{thJC}$ $R_{thCS}$ $R_{thJA}$				0.28 $^\circ\text{C/W}$
		0.05		$^\circ\text{C/W}$
		19		$^\circ\text{C/W}$

**Reverse Diode (FRED)**

Symbol Test Conditions ( $T_J = 25^\circ\text{C}$ Unless Otherwise Specified)		Characteristic Values		
		Min.	Typ.	Max.
$V_F$	$I_F = 100\text{A}, V_{GK} = 0\text{V}, \text{Note 1}$			1.8 V
$I_{RM}$ $t_{rr}$	$I_F = 50\text{A}, V_{GK} = 0\text{V},$ $-di_F/dt = 200\text{A}/\mu\text{s}, V_R = 300\text{V}$		20	A
			700	ns
$R_{thJC}$				0.50 $^\circ\text{C/W}$

**Notes:**

1. Pulse test,  $t \leq 300\mu\text{s}$ , duty cycle,  $d \leq 2\%$ .
2. It is recommended to use a gate driver capable of supplying more than 4Amps and  $\geq 15\text{V}$  gate voltage.
3. Refer to fig. 9 & 10.

**PRELIMINARY TECHNICAL INFORMATION**

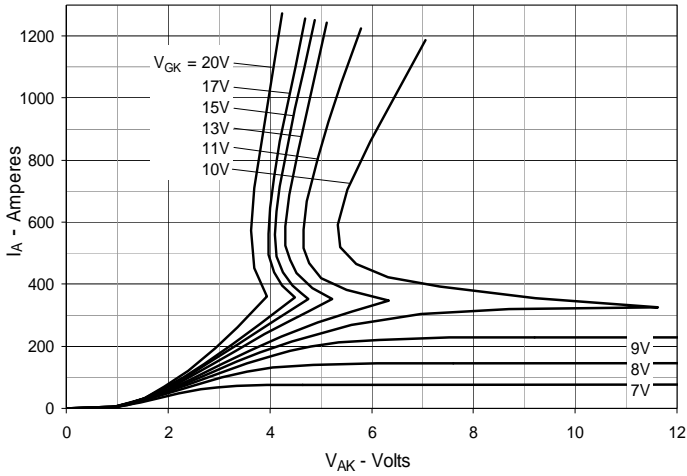
The product presented herein is under development. The Technical Specifications offered are derived from a subjective evaluation of the design, based upon prior knowledge and experience, and constitute a "considered reflection" of the anticipated result. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

IXYS Reserves the Right to Change Limits, Test Conditions, and Dimensions.

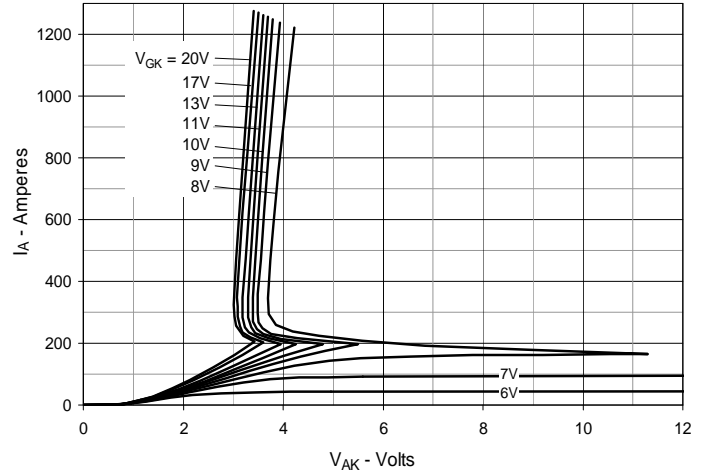
IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents:

4,835,592	4,931,844	5,049,961	5,237,481	6,162,665	6,404,065 B1	6,683,344	6,727,585	7,005,734 B2	7,157,338B2
4,860,072	5,017,508	5,063,307	5,381,025	6,259,123 B1	6,534,343	6,710,405 B2	6,759,692	7,063,975 B2	
4,881,106	5,034,796	5,187,117	5,486,715	6,306,728 B1	6,583,505	6,710,463	6,771,478 B2	7,071,537	

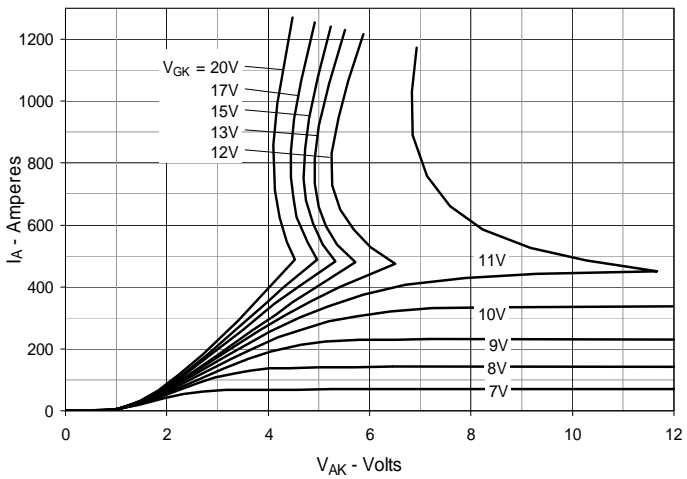
**Fig. 1. Extended Output Characteristics @  $T_J = 25^\circ\text{C}$**



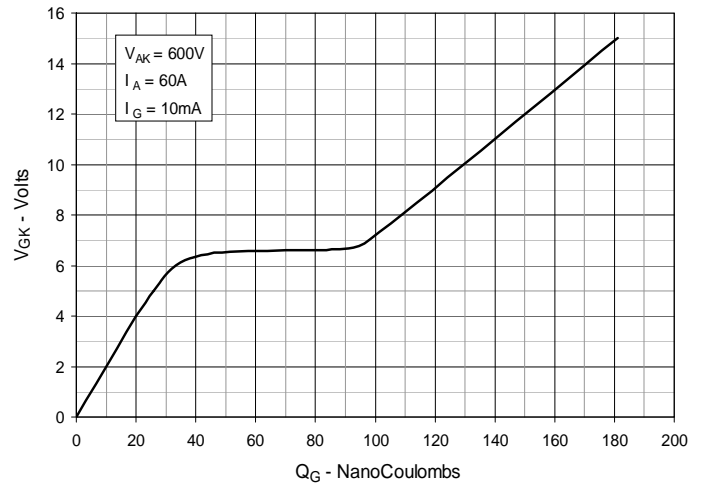
**Fig. 2. Extended Output Characteristics @  $T_J = 125^\circ\text{C}$**



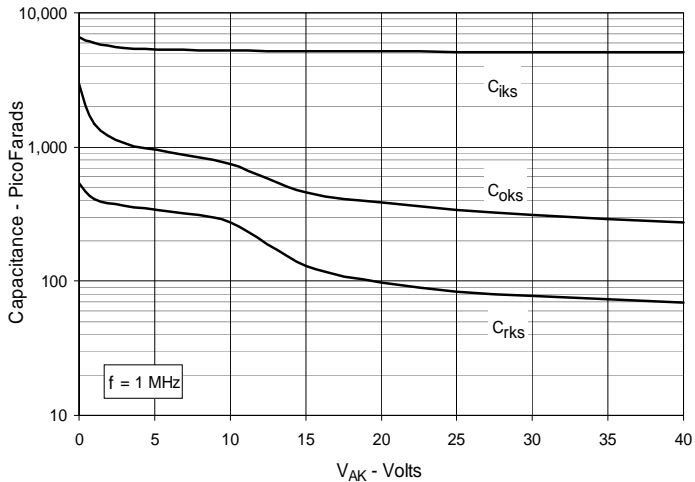
**Fig. 3. Extended Output Characteristics @  $T_J = -40^\circ\text{C}$**



**Fig. 4. Gate Charge**



**Fig. 5. Capacitance**



**Fig. 6. Forward Voltage Drop of Intrinsic Diode**

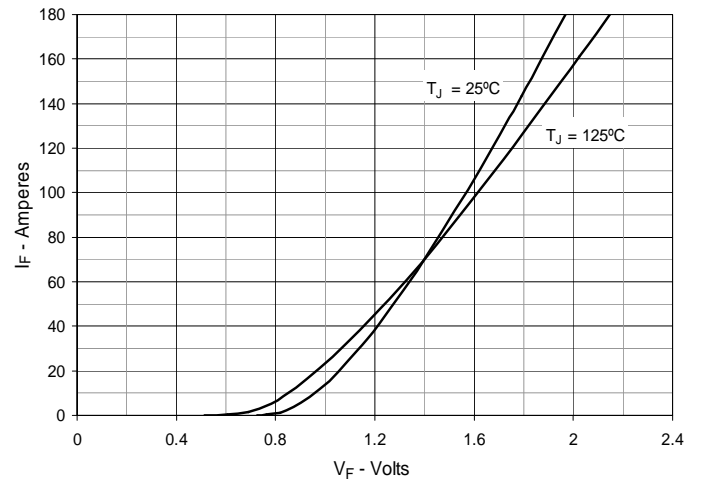


Fig. 7. Maximum Transient Thermal Impedance

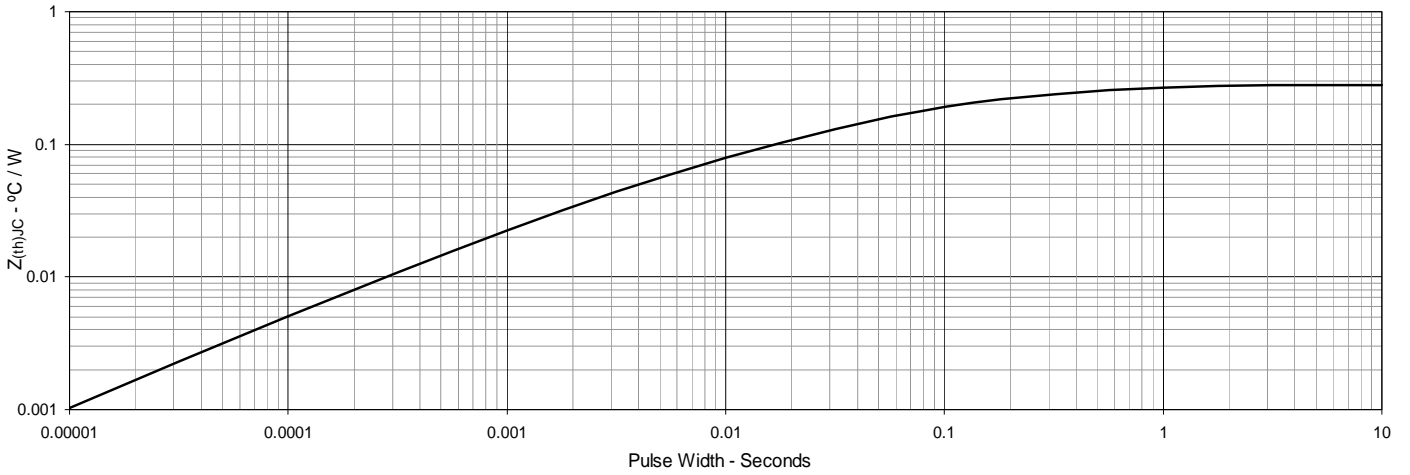
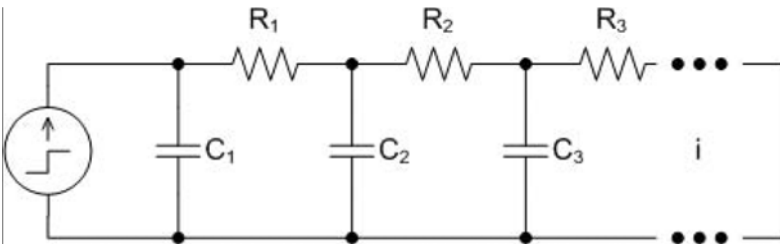


Fig. 8. Cauer Thermal Network



i	Ri (Ω)	Ci (F)
1	0.018327	0.024851
2	0.052439	0.058268
3	0.099100	0.208110
4	0.048364	4.000000

Fig. 9. Capacitive Discharge Circuit

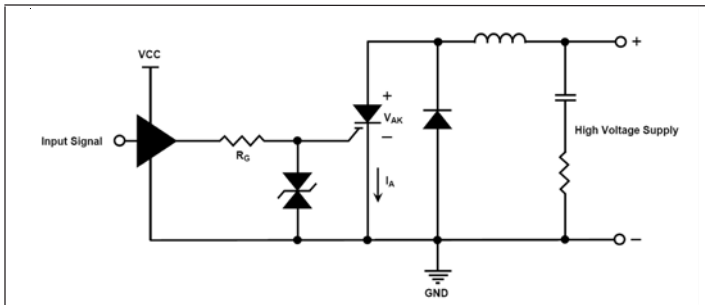
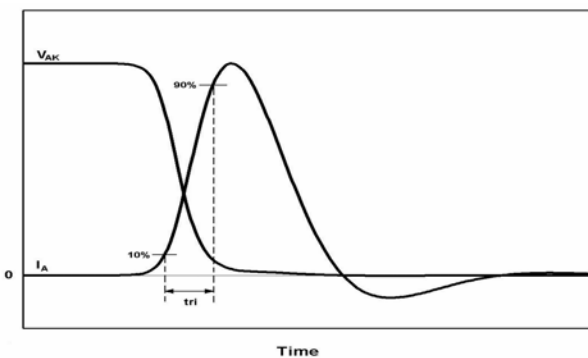
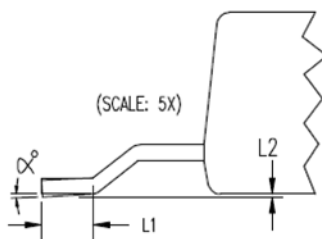
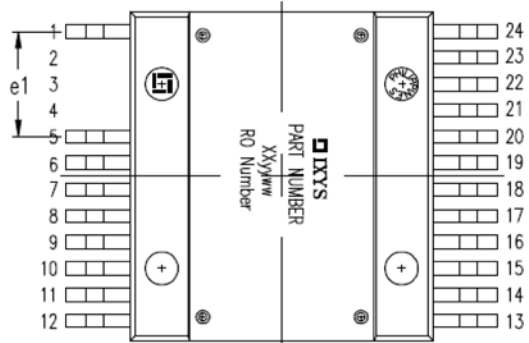
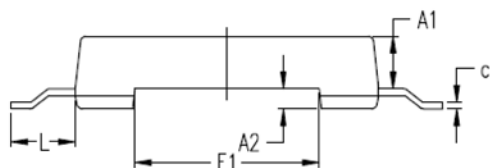
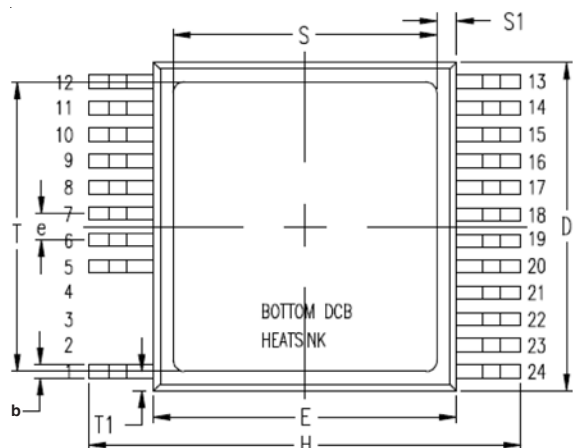


Fig. 10. Capacitive Discharge Waveform





**PIN:** 1 = Gate  
 5-12 = Cathode  
 13-24 = Anode

Dim.	Millimeter		Inches	
	min	max	min	max
A	5.30	5.70	0.209	0.224
A1	3.90	4.10	0.154	0.161
A2	1.40	1.60	0.055	0.063
b	0.90	1.15	0.035	0.045
c	0.45	0.65	0.018	0.026
D	24.80	25.25	0.976	0.994
E	22.80	23.25	0.898	0.915
E1	13.80	14.20	0.543	0.559
e	2.00	BSC	0.079	BSC
e1	8.00	BSC	0.315	BSC
H	32.30	33.30	1.272	1.311
L	4.60	5.30	0.181	0.209
L1	1.30	1.70	0.051	0.067
L2	0.00	0.15	0.000	0.006
S	18.85	20.12	0.742	0.792
S1	1.45	2.08	0.057	0.082
T	20.90	22.17	0.823	0.873
T1	1.42	2.03	0.056	0.080
a	4°	-	4°	-



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